

**Notice of References Cited**

Application/Control No.

09/718.669

Applicant(s)/Patent Under  
Reexamination  
YUAN ET AL

Examiner

DiLinh Nguyen

Art Unit

2814

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6265762	07-2002	Tanaka et al.	257
	B	US-6060770	05-2000	Nakamura et al.	257
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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